



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AON6661**

**30V Dual Complementary MOSFET**

### General Description

- Trench Power MOSFET technology
- Low  $R_{DS(ON)}$
- Low Gate Charge
- Excellent Thermal Performance
- RoHS and Halogen-Free Compliant

### Product Summary

|                                  | <u>Q1</u> | <u>Q2</u> |
|----------------------------------|-----------|-----------|
| $V_{DS}$                         | 30V       | -30V      |
| $I_D$ (at $V_{GS}=10V$ )         | 16A       | -16A      |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 14mΩ    | < 22mΩ    |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 18mΩ    | < 35mΩ    |

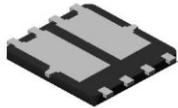
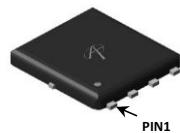
### Applications

- Pch+Nch Complementary MOSFET for DC-FAN

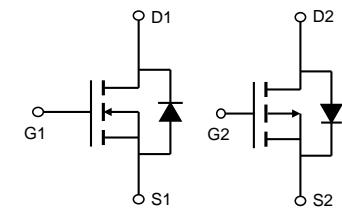
100% UIS Tested  
100% Rg Tested



DFN5X6 EP2



Top View



### Orderable Part Number

AON6661

### Package Type

DFN 5x6

### Form

Tape & Reel

### Minimum Order Quantity

3000

### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                               | Symbol         | Max Q1     | Max Q2   | Units |
|-----------------------------------------|----------------|------------|----------|-------|
| Drain-Source Voltage                    | $V_{DS}$       | 30         | -30      | V     |
| Gate-Source Voltage                     | $V_{GS}$       | $\pm 20$   | $\pm 20$ | V     |
| Continuous Drain Current <sup>G</sup>   | $I_D$          | 16         | -16      | A     |
| $T_C=100^\circ C$                       |                | 16         | -12.5    |       |
| Pulsed Drain Current <sup>C</sup>       | $I_{DM}$       | 50         | -65      |       |
| Continuous Drain Current                | $I_{DSM}$      | 13         | 11       | A     |
| $T_A=70^\circ C$                        |                | 10         | -8.5     |       |
| Avalanche Current <sup>C</sup>          | $I_{AS}$       | 22         | -27      | A     |
| Avalanche energy $L=0.1mH$ <sup>C</sup> | $E_{AS}$       | 24         | 36       | mJ    |
| $V_{DS}$ Spike                          | $V_{SPIKE}$    | 36         | -36      | V     |
| Power Dissipation <sup>B</sup>          | $P_D$          | 12.5       | 20       | W     |
| $T_C=100^\circ C$                       |                | 5          | 8        |       |
| Power Dissipation <sup>A</sup>          | $P_{DSM}$      | 3.5        | 4.1      | W     |
| $T_A=70^\circ C$                        |                | 2.2        | 2.6      |       |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$ | -55 to 150 |          |       |
|                                         |                |            |          | °C    |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ Q1          | Typ Q2 | Max Q1 | Max Q2 | Units |      |
|--------------------------------------------|-----------------|-----------------|--------|--------|--------|-------|------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 25              | 20     | 35     | 30     | °C/W  |      |
| Maximum Junction-to-Ambient <sup>A D</sup> |                 | 50              | 48     | 70     | 65     | °C/W  |      |
| Maximum Junction-to-Case                   | Steady-State    | $R_{\theta JC}$ | 7      | 5      | 10     | 6     | °C/W |

**Q1 Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                              | Min | Typ  | Max | Units |
|-----------------------------|---------------------------------------|-----------------------------------------------------------------------------------------|-----|------|-----|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                         |     |      |     |       |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | ID=250μA, VGS=0V                                                                        | 30  |      |     | V     |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>$T_J=55^\circ\text{C}$                     |     | 1    | 5   | μA    |
| $I_{GSS}$                   | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V                                              |     |      | 100 | nA    |
| $V_{GS(\text{th})}$         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                | 1.5 | 1.9  | 2.5 | V     |
| $R_{DS(\text{ON})}$         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =12A<br>$T_J=125^\circ\text{C}$                    | 11  | 14   | 20  | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A                                              |     | 16   | 18  | mΩ    |
| $g_{FS}$                    | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =12A                                                |     | 43   |     | S     |
| $V_{SD}$                    | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                 |     | 0.75 | 1   | V     |
| $I_S$                       | Maximum Body-Diode Continuous Current |                                                                                         |     |      | 10  | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                         |     |      |     |       |
| $C_{iss}$                   | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz                                       |     | 760  |     | pF    |
| $C_{oss}$                   | Output Capacitance                    |                                                                                         |     | 125  |     | pF    |
| $C_{rss}$                   | Reverse Transfer Capacitance          |                                                                                         |     | 70   |     | pF    |
| $R_g$                       | Gate resistance                       | f=1MHz                                                                                  | 0.8 | 1.6  | 2.4 | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                         |     |      |     |       |
| $Q_g(10V)$                  | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =12A                         |     | 14   | 20  | nC    |
| $Q_g(4.5V)$                 | Total Gate Charge                     |                                                                                         |     | 6.6  | 10  | nC    |
| $Q_{gs}$                    | Gate Source Charge                    |                                                                                         |     | 2.4  |     | nC    |
| $Q_{gd}$                    | Gate Drain Charge                     |                                                                                         |     | 3    |     | nC    |
| $t_{D(on)}$                 | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =1.25Ω, R <sub>GEN</sub> =3Ω |     | 4.4  |     | ns    |
| $t_r$                       | Turn-On Rise Time                     |                                                                                         |     | 9    |     | ns    |
| $t_{D(off)}$                | Turn-Off DelayTime                    |                                                                                         |     | 17   |     | ns    |
| $t_f$                       | Turn-Off Fall Time                    |                                                                                         |     | 6    |     | ns    |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | I <sub>F</sub> =12A, di/dt=500A/μs                                                      |     | 7    |     | ns    |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =12A, di/dt=500A/μs                                                      |     | 8    |     | nC    |

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{ C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{ C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{ C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{ C}$ .

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{ C}$ . The SOA curve provides a single pulse rating.

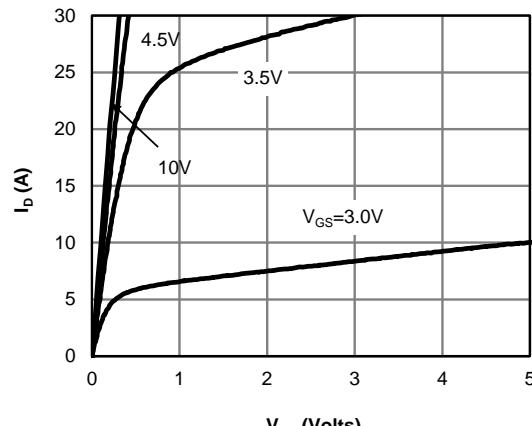
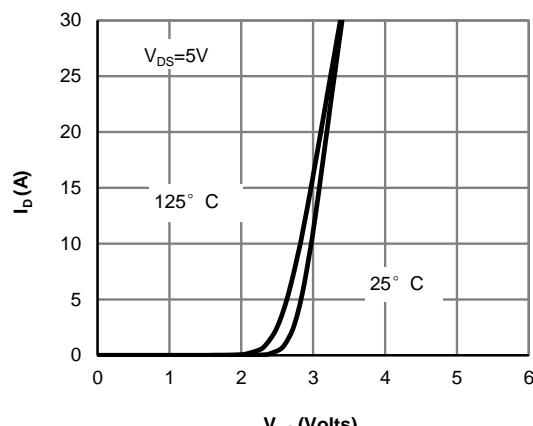
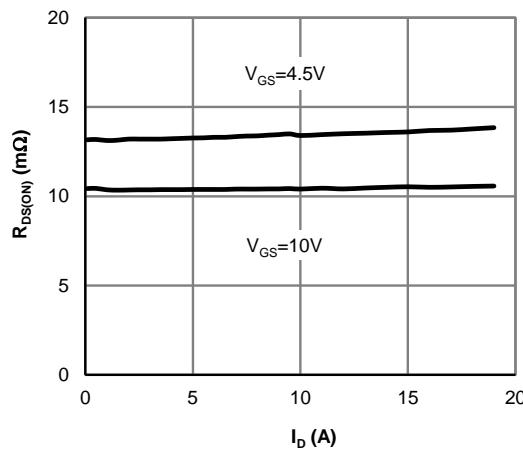
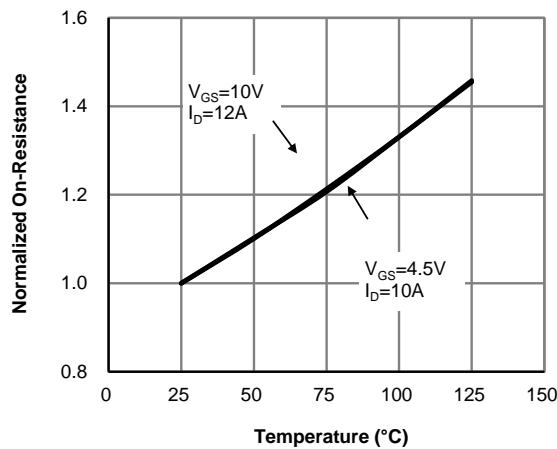
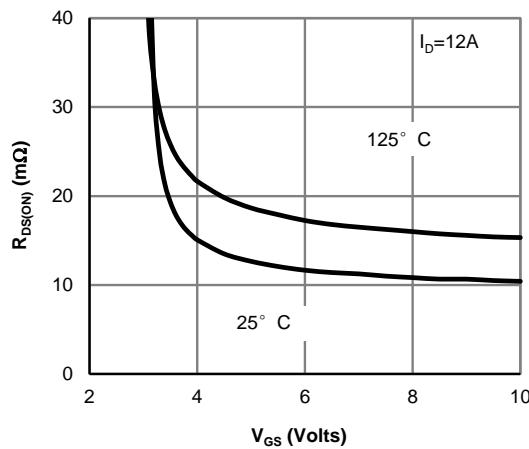
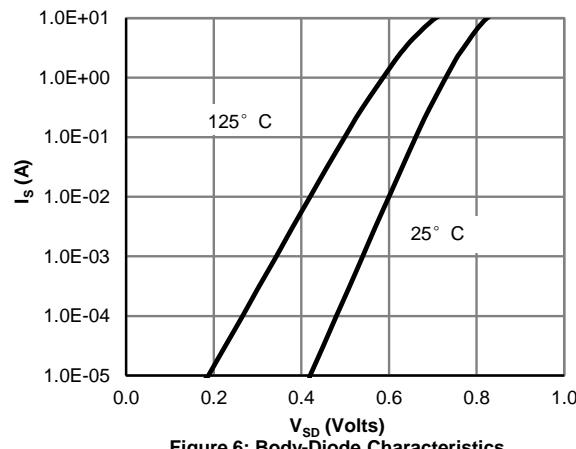
G. The maximum current rating is package limited.

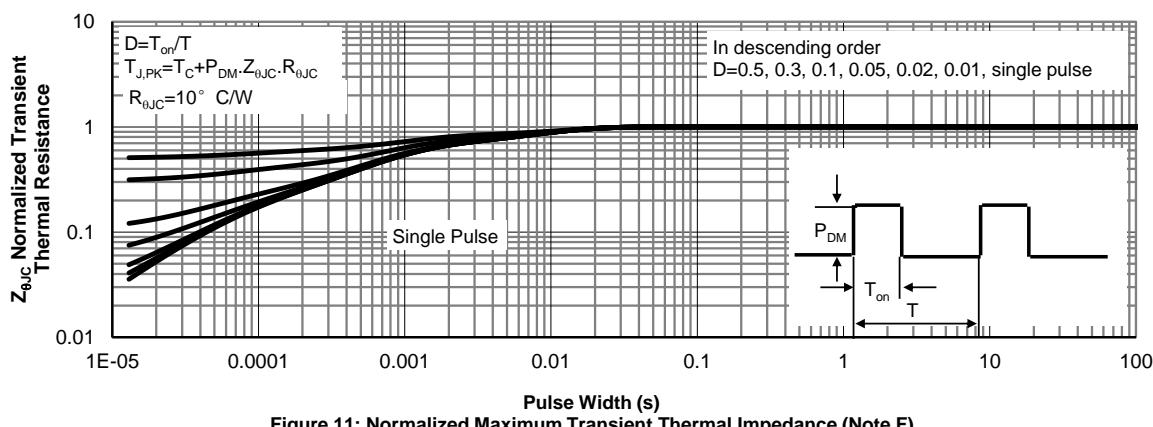
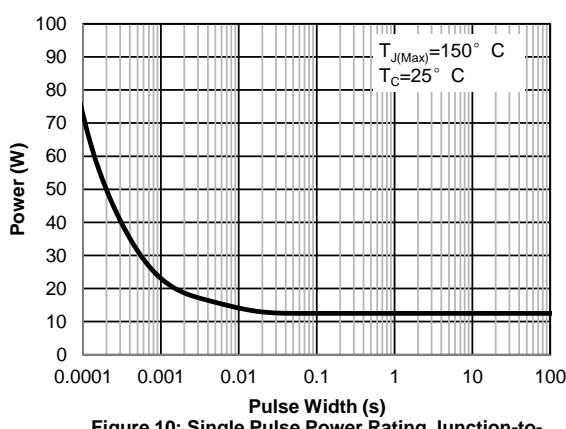
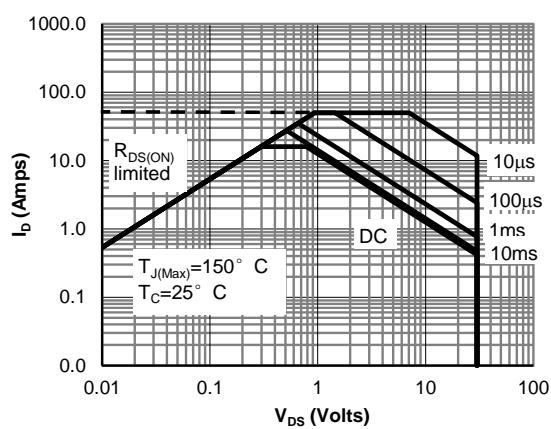
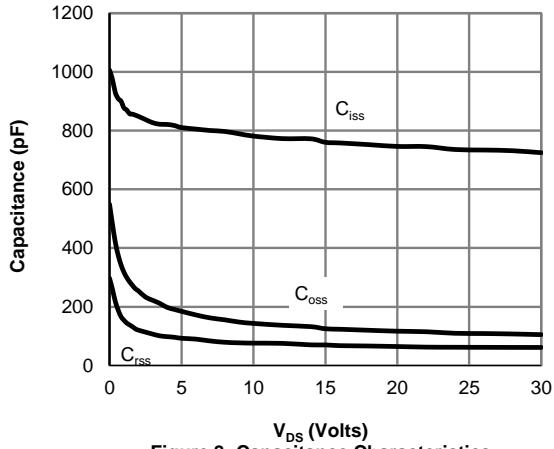
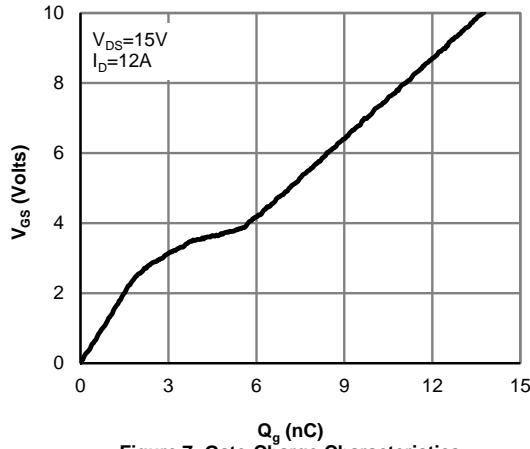
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{ C}$ .

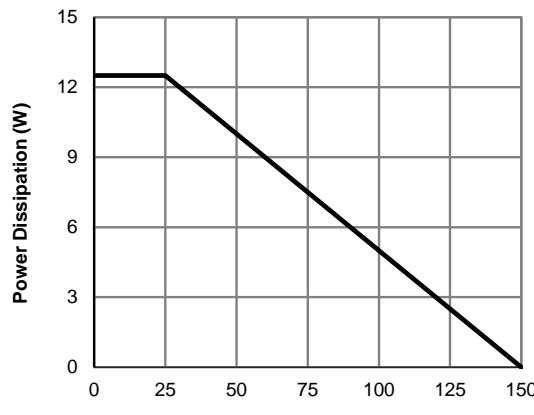
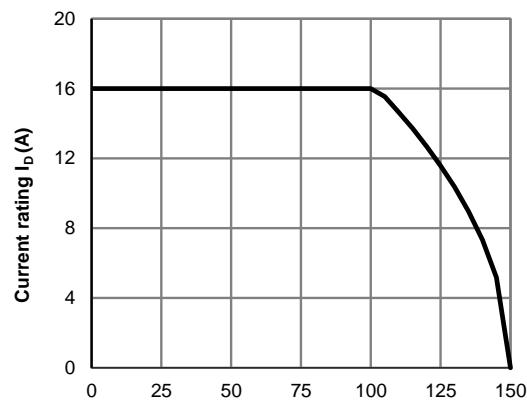
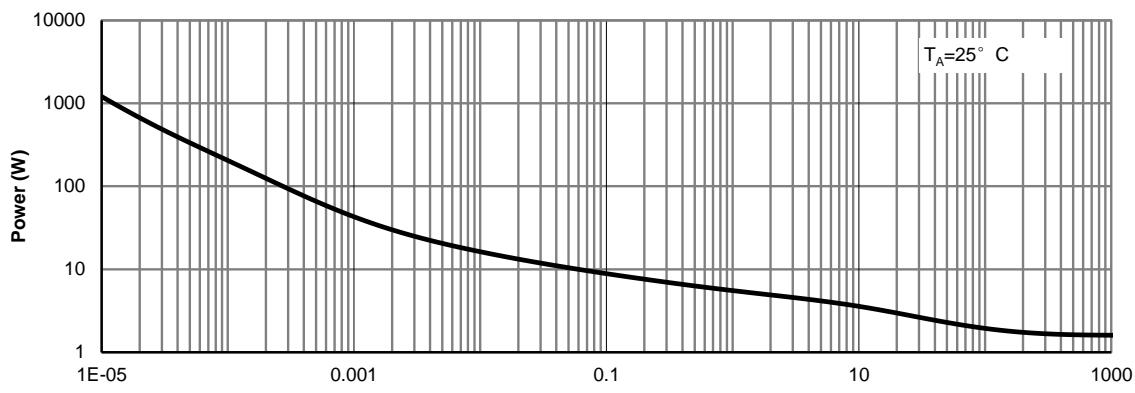
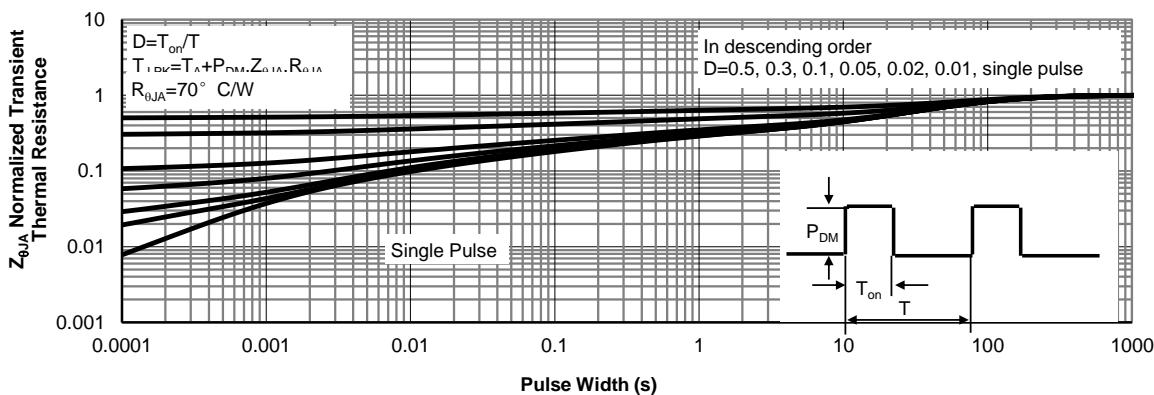
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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 1: On-Region Characteristics (Note E)**

**Figure 2: Transfer Characteristics (Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


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**Figure 12: Power De-rating (Note F)**

**Figure 13: Current De-rating (Note F)**

**Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)**

**Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)**

**Q2 Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                                          | Conditions                                                                      | Min  | Typ   | Max      | Units            |
|-----------------------------|----------------------------------------------------|---------------------------------------------------------------------------------|------|-------|----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                                    |                                                                                 |      |       |          |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage                     | $I_D=-250\mu\text{A}, V_{GS}=0\text{V}$                                         | -30  |       |          | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current                    | $V_{DS}=-30\text{V}, V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                |      | -1    | -5       | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current                          | $V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$                                        |      |       | $\pm100$ | nA               |
| $V_{GS(\text{th})}$         | Gate Threshold Voltage                             | $V_{DS}=V_{GS}, I_D=-250\mu\text{A}$                                            | -1.5 | -2.0  | -2.5     | V                |
| $R_{DS(\text{ON})}$         | Static Drain-Source On-Resistance                  | $V_{GS}=-10\text{V}, I_D=-9.7\text{A}$<br>$T_J=125^\circ\text{C}$               | 16.5 | 22    |          | $\text{m}\Omega$ |
|                             |                                                    | $V_{GS}=-4.5\text{V}, I_D=-7\text{A}$                                           | 24   | 32    |          | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance                           | $V_{DS}=-5\text{V}, I_D=-9.7\text{A}$                                           | 27   |       |          | S                |
| $V_{SD}$                    | Diode Forward Voltage                              | $I_S=-1\text{A}, V_{GS}=0\text{V}$                                              |      | -0.75 | -1       | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current <sup>G</sup> |                                                                                 |      |       | -16      | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                                    |                                                                                 |      |       |          |                  |
| $C_{iss}$                   | Input Capacitance                                  | $V_{GS}=0\text{V}, V_{DS}=-15\text{V}, f=1\text{MHz}$                           |      | 1040  |          | pF               |
| $C_{oss}$                   | Output Capacitance                                 |                                                                                 |      | 180   |          | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance                       |                                                                                 |      | 125   |          | pF               |
| $R_g$                       | Gate resistance                                    | $f=1\text{MHz}$                                                                 | 2    | 4     | 6        | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                                    |                                                                                 |      |       |          |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                                  | $V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, I_D=-9.7\text{A}$                      |      | 19    | 30       | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                                  |                                                                                 |      | 9.6   | 15       | nC               |
| $Q_{gs}$                    | Gate Source Charge                                 |                                                                                 |      | 3.6   |          | nC               |
| $Q_{gd}$                    | Gate Drain Charge                                  |                                                                                 |      | 4.6   |          | nC               |
| $t_{D(\text{on})}$          | Turn-On DelayTime                                  | $V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, R_L=1.5\Omega, R_{\text{GEN}}=3\Omega$ |      | 10    |          | ns               |
| $t_r$                       | Turn-On Rise Time                                  |                                                                                 |      | 5.5   |          | ns               |
| $t_{D(\text{off})}$         | Turn-Off DelayTime                                 |                                                                                 |      | 26.0  |          | ns               |
| $t_f$                       | Turn-Off Fall Time                                 |                                                                                 |      | 9     |          | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time                   | $I_F=-9.7\text{A}, dI/dt=500\text{A}/\mu\text{s}$                               |      | 11.5  |          | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge                 | $I_F=-9.7\text{A}, dI/dt=500\text{A}/\mu\text{s}$                               |      | 25    |          | nC               |

A. The value of  $R_{\text{BJA}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\text{BJA}} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ .

D. The  $R_{\text{BJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{JC}}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 $\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

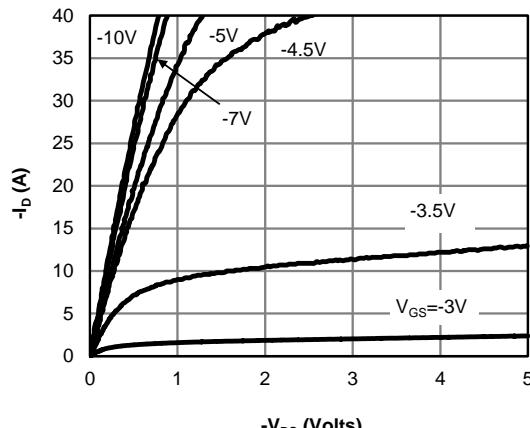
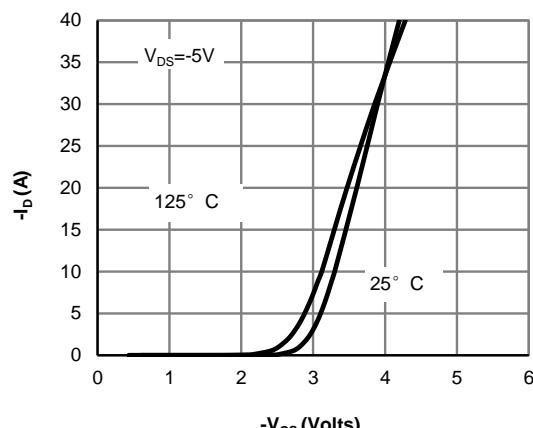
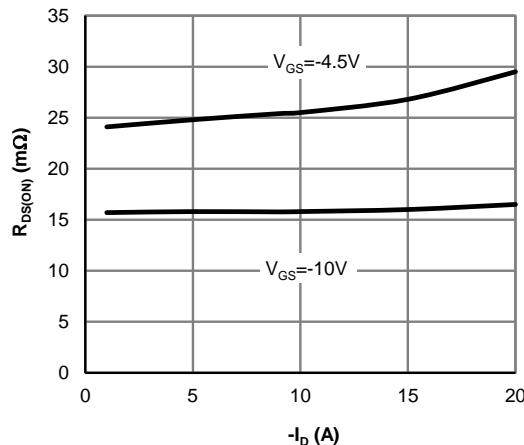
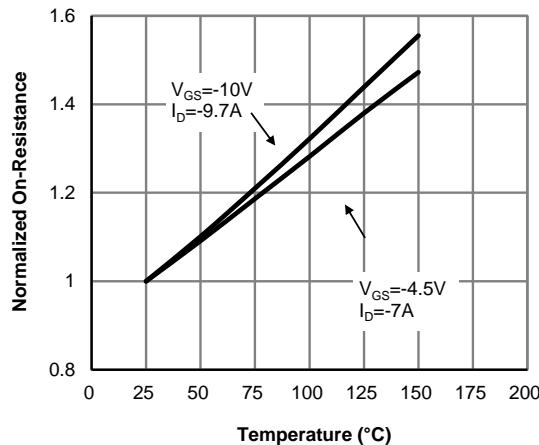
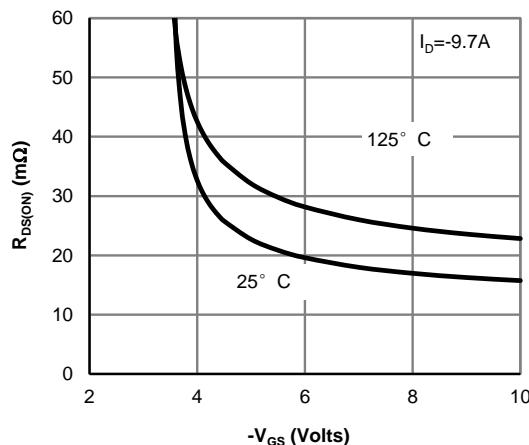
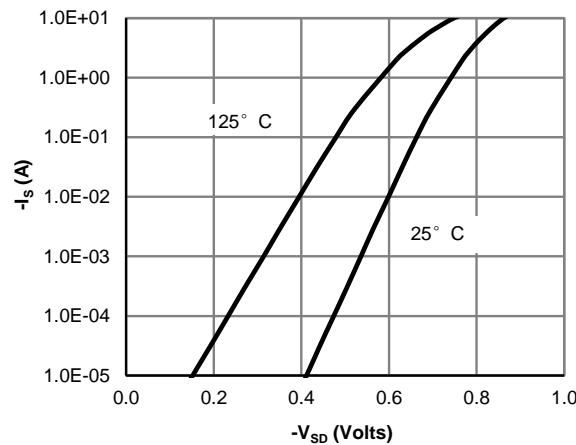
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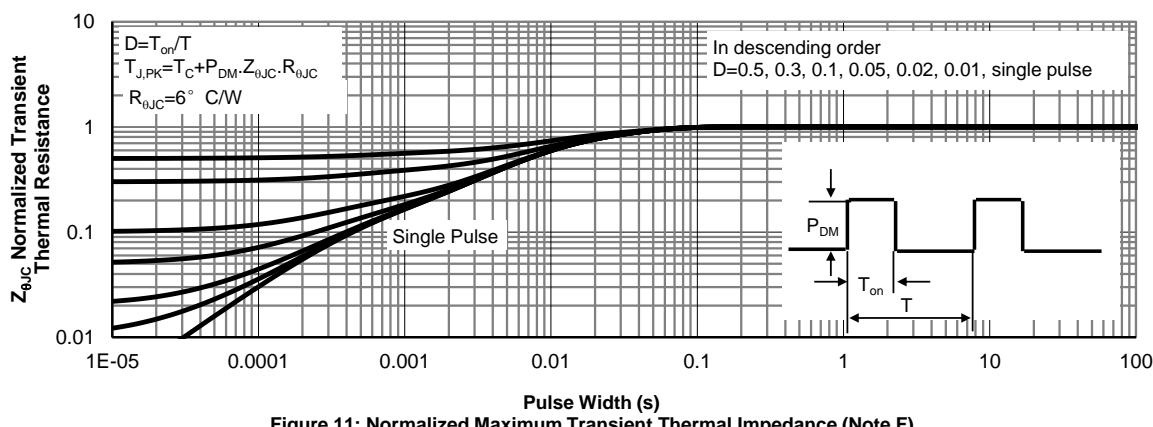
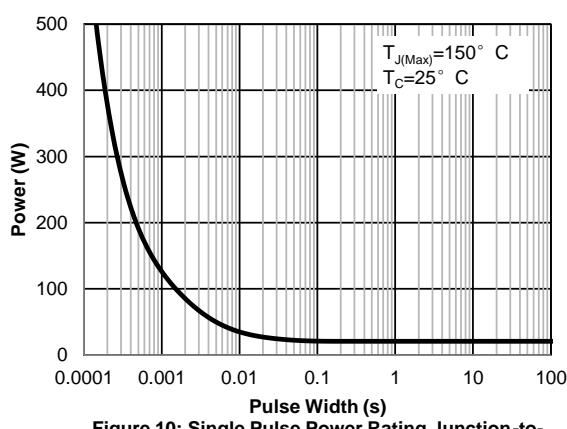
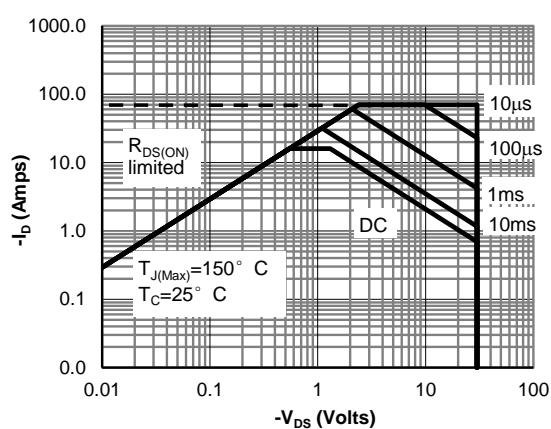
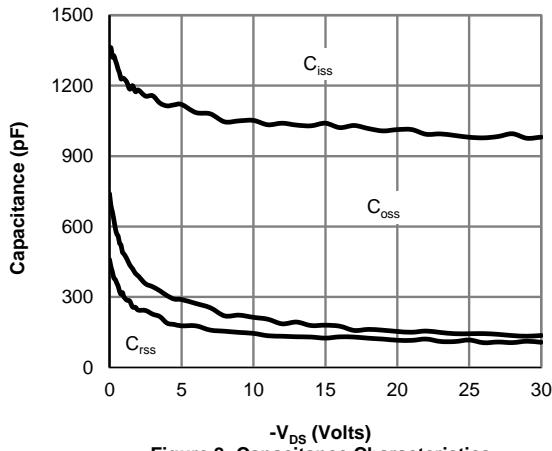
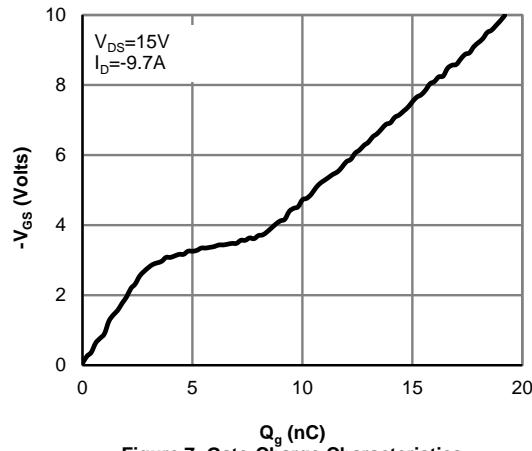
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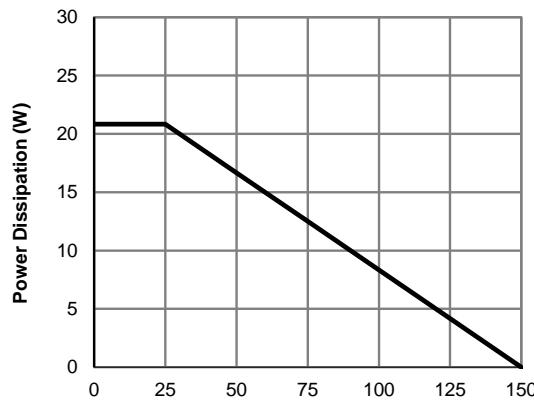
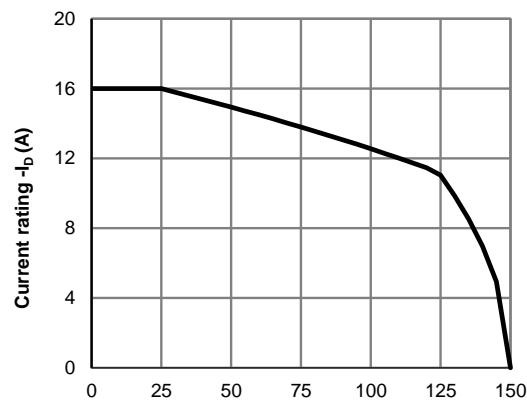
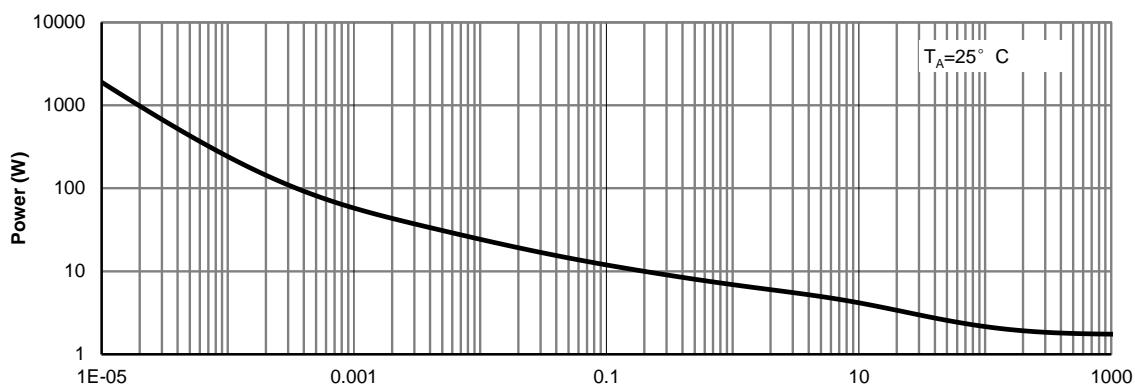
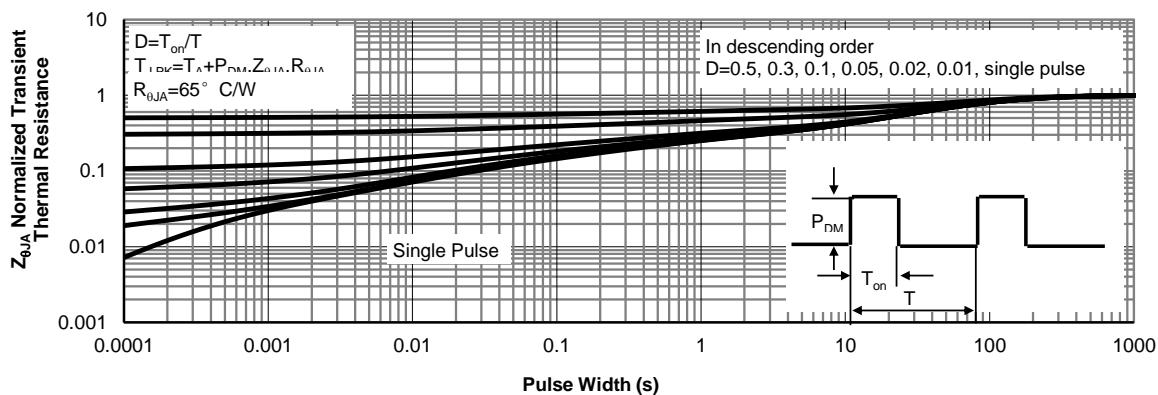
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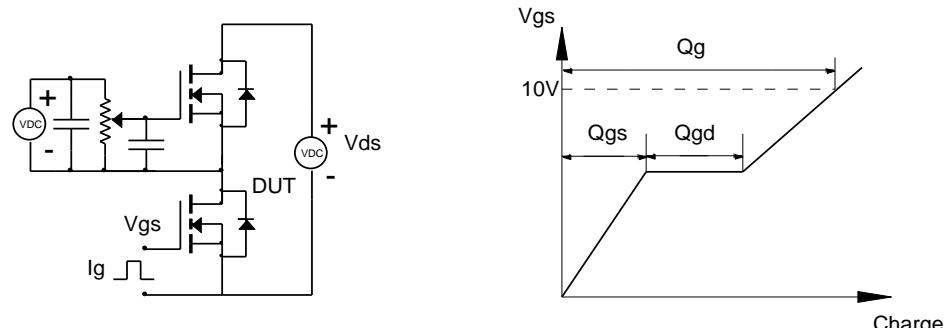
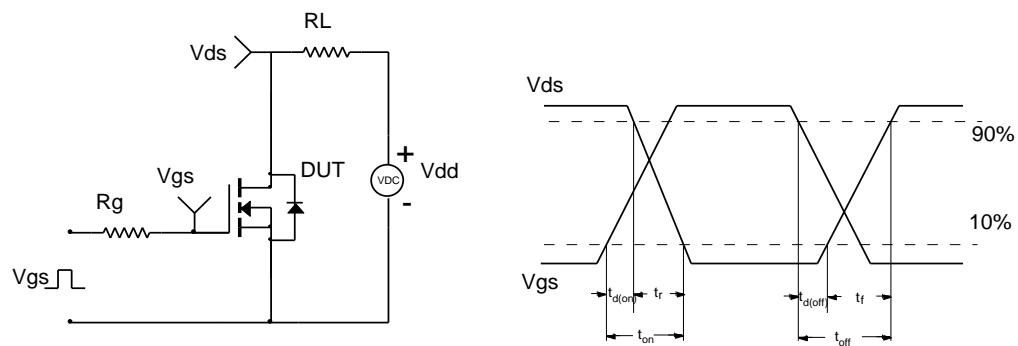
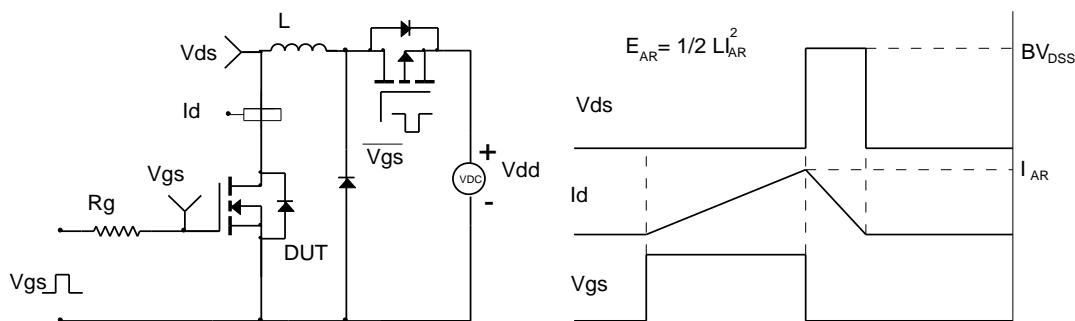
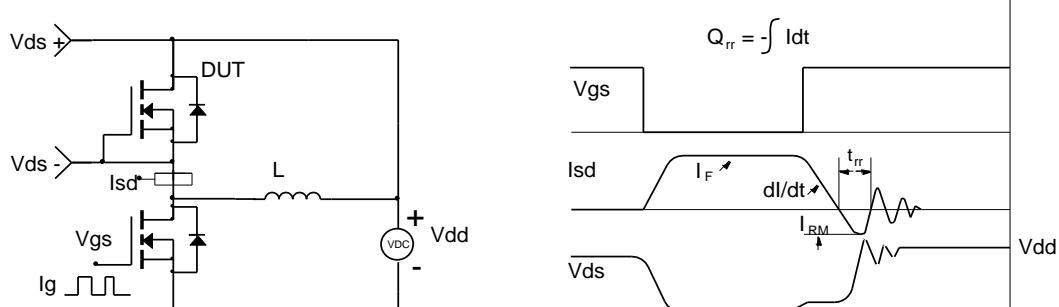
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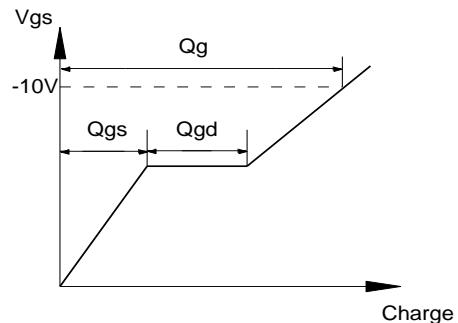
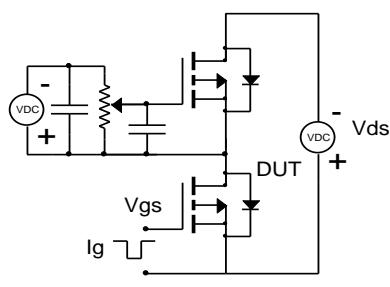
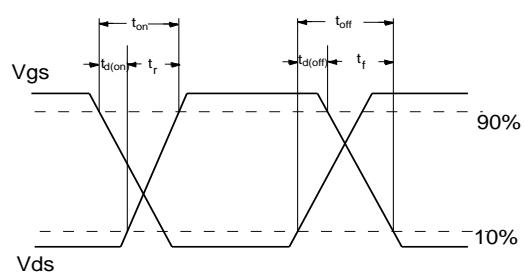
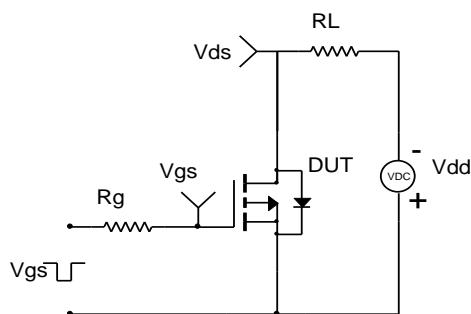
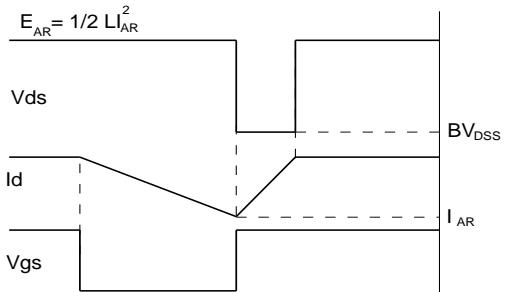
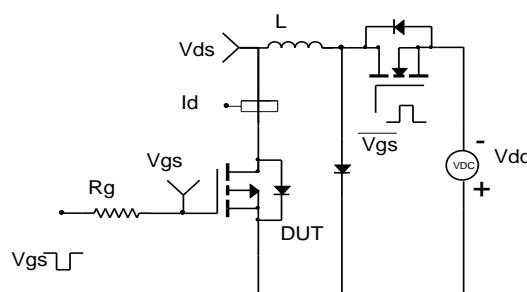
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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 1: On-Region Characteristics (Note E)**

**Figure 2: Transfer Characteristics (Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


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**Figure 12: Power De-rating (Note F)**

**Figure 13: Current De-rating (Note F)**

**Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)**

**Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)**

**Figure A: Gate Charge Test Circuit & Waveforms**

**Figure B: Resistive Switching Test Circuit & Waveforms**

**Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**

**Figure D: Diode Recovery Test Circuit & Waveforms**


**Gate Charge Test Circuit & Waveform**

**Resistive Switching Test Circuit & Waveforms**

**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**

**Diode Recovery Test Circuit & Waveforms**
